

WNSC10650T

Silicon Carbide Diode

Rev.01 - 04 March 2020

Product data sheet

1. General description

Silicon Carbide Schottky diode in a DFN 8*8 plastic package, designed for high frequency switched-mode power supplies.



2. Features and benefits

- Highly stable switching performance
- High forward surge capability I_{FSM}
- Extremely fast reverse recovery time
- · Superior in efficiency to Silicon Diode alternatives
- Reduced losses in associated MOSFET
- Reduced EMI
- Reduced cooling requirements
- RoHS compliant

3. Applications

- Power factor correction
- Telecom / Server SMPS
- UPS
- PV inverter
- PC Silverbox
- LED / OLED TV
- Motor Drives

4. Quick reference data

able 1. Q	uick reference data						
Symbol	Parameter	Conditions	Values			Unit	
Absolute	e maximum rating						
V_{RRM}	repetitive peak reverse voltage			6	50		V
$I_{F(AV)}$	average forward current	δ = 0.5 ; square-wave pulse; T _c ≤ 142 °C; Fig. 1; Fig. 2; Fig. 3		10		A	
Tj	junction temperature			175		°C	
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static ch	aracteristics						
V _F	forward voltage	I _F = 10 A; T _j = 25 °C; <u>Fig. 5</u>		-	1.5	1.7	V
		I _F = 10 A; T _j = 150 °C; <u>Fig. 5</u>		-	1.68	2	V
Dynamic	characteristics						
Q _r	recovered charge	$I_F = 10 \text{ A}; \text{ d}I_F/\text{d}t = 500 \text{ A}/\mu\text{s}; V_R = 400 \text{ V};$ $T_j = 25 \text{ °C}; \text{ Fig. 7}$		-	16	-	nC

5. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	n.c.	not connected	[]	к-Ң-А
2	n.c.	not connected	5	001aaa020
3	А	anode		
4	А	anode		
5	К	mounting base; connected to cathode	1 2 3 4	

6. Ordering information

Table 3. Ordering information								
Type number	Package	Orderable part number	U	Small packing		Package		
	name		method	quantity	version	issue date		
WNSC10650T	DFN8*8	WNSC10650T6J	Таре	3000	DFN8X8N	26-Dec-2019		

7. Marking

Table 4. Marking codes					
Type number	Marking codes				
WNSC10650T	WNSC 10650T				

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
V_{RRM}	repetitive peak reverse voltage		650	V
V_{RWM}	crest working reverse voltage		650	V
V _R	reverse voltage	DC	650	V
$I_{F(AV)}$	average forward current	δ = 0.5; square-wave pulse; T _c ≤ 142 °C; Fig. 1; Fig. 2; Fig. 3	10	A
I _{FRM}	repetitive peak forward current	δ = 0.5; t _p = 25 µs; T _c ≤ 142 °C; square-wave pulse	20	A
I _{FSM}	non-repetitive peak	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse	50	А
	forward current	t_p = 10 µs; $T_{j(init)}$ = 25 °C; square-wave pulse	450	А
l ² t	I ² t for fusing	sine-wave pulse; $T_{j(init)}$ = 25 °C; t_p = 10 ms	13	A ² s
T _{stg}	storage temperature		-55 to 175	°C
T_j	junction temperature		175	°C

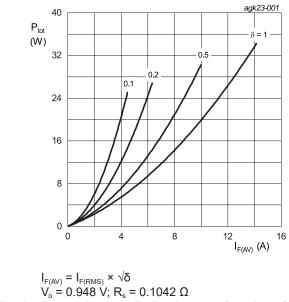
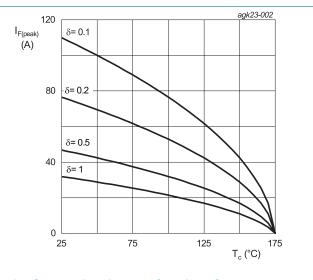
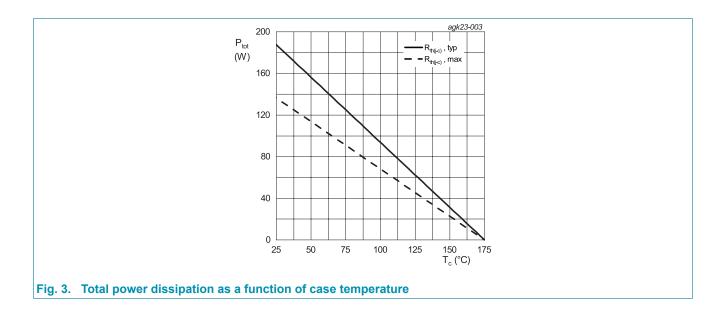


Fig. 1. Forward power dissipation as a function of average forward current; square waveform; maximum values



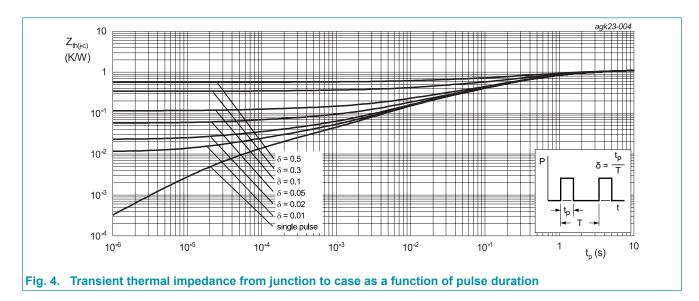


WNSC10650T Silicon Carbide Diode



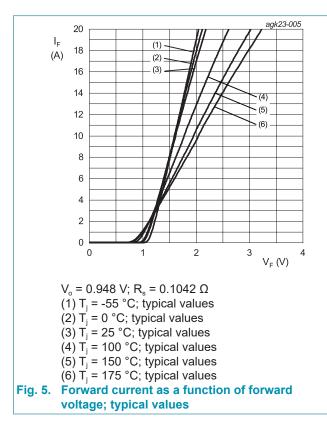
9. Thermal characteristics

Table 6. Th	ermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	Fig. 4	-	0.8	1.1	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient free air	in free air	-	50	-	K/W



10. Characteristics

Symbol	Parameter	Conditions	Mir	Тур	Max	Unit
Static cha	aracteristics			· · ·		
V _F	forward current	I _F = 10 A; T _j = 25 °C; <u>Fig. 5</u>	-	1.5	1.7	V
		I _F = 10 A; T _j = 150 °C; <u>Fig. 5</u>	-	1.68	2	V
		I _F = 10 A; T _j = 175 °C; <u>Fig. 5</u>	-	1.75	2.1	V
I _R	reverse current	V _R = 650 V; T _j = 25 °C; <u>Fig. 6</u>	-	-	60	μA
		V _R = 650 V; T _j = 175 °C; <u>Fig. 6</u>	-	-	240	μA
Dynamic	characteristics	· · · · · ·	I	I		
Q _r	recovered charge	$I_{F} = 10 \text{ A}; V_{R} = 400 \text{ V}; \text{ d}I_{F}/\text{d}t = 500 \text{ A}/\mu\text{s}; T_{j} = 25 ^{\circ}\text{C}; \text{ Fig. 7}$	-	16	-	nC
C _d	diode capacitance	f = 1 MHz; V _R = 1 V; T _j = 25 °C	-	328	-	pF
		f = 1 MHz; V _R = 300 V; T _j = 25 °C	-	38	-	pF
		f = 1 MHz; V _R = 600 V; T _j = 25 °C	-	34	-	pF
E _{as}	non-repetitive avalanche energy	I _R = 5.5 A; L = 5 mH; T _{j(init)} = 25 °C	75	-	-	mJ



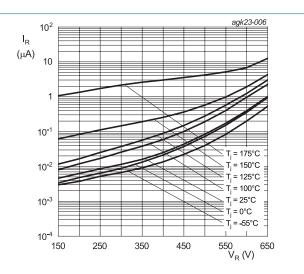
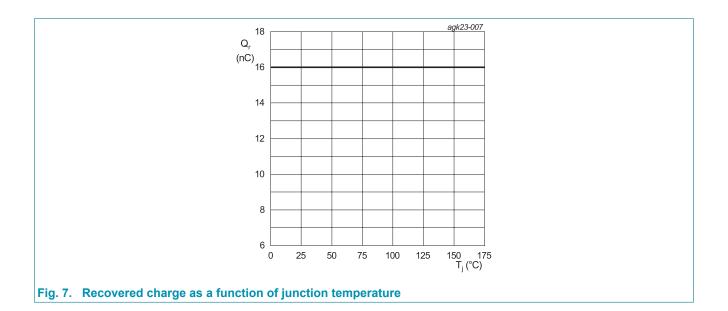
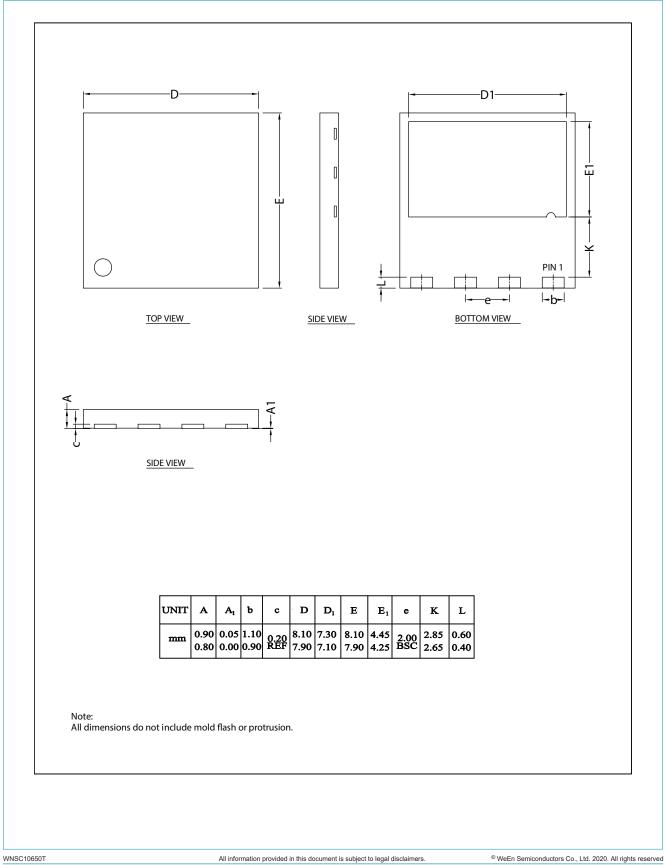


Fig. 6. Reverse leakage current as a function of reverse voltage; typical value

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11. Package outline



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

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